

Resource Summary Report

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Rigaku: AZX 400

RRID:SCR_020439

Type: Tool

Proper Citation

Rigaku: AZX 400 (RRID:SCR_020439)

Resource Information

URL: <https://www.rigaku.com/products/semi/azx400>

Proper Citation: Rigaku: AZX 400 (RRID:SCR_020439)

Description: Sequential wavelength dispersive XRF spectrometer for large samples film thickness and composition measurements on large and heavy samples, wafers, and media disks.

Resource Type: instrument resource

Keywords: Rigaku, Spectrometer, Instrument, Equipment, USEDit,

Availability: Commercially available

Resource Name: Rigaku: AZX 400

Resource ID: SCR_020439

Alternate IDs: Model_Number_AZX 400

Record Creation Time: 20220129T080350+0000

Record Last Update: 20260725T190928+0000

Ratings and Alerts

No rating or validation information has been found for Rigaku: AZX 400.

No alerts have been found for Rigaku: AZX 400.

Data and Source Information

Source: [SciCrunch Registry](#)

Usage and Citation Metrics

We have not found any literature mentions for this resource.